

# RAD1419 Analog-to-Digital Converter

## Data Sheet

September, 2012

www.aeroflex.com/AtoD



### FEATURES

- ❑ 800 kSPS sample rate
- ❑ 150mW power dissipation
- ❑ Typical performance: 81.5dB S/(N + D) and 93dB THD
- ❑ No pipeline delays or missing codes
- ❑ Nap and shutdown modes
- ❑ Operates with 2.5V internal 15ppm/°C reference or external reference
- ❑ True differential inputs reject common mode noise
- ❑ 20MHz full-power bandwidth sampling
- ❑ Bipolar input range:  $\pm 2.5V$
- ❑ Operational Environment; total dose irradiation testing to MIL-STD-883 Method 1019
  - Total-dose: 100 krad(Si)
  - Latchup immune ( $LET \leq 55 \text{ MeV-cm}^2/\text{mg}$ )
- ❑ Packaging options:
  - 28-lead hermetic ceramic flatpack
- ❑ Class S A-to-D Converter built to your custom flow

### INTRODUCTION

Aeroflex RAD's RAD1419 Analog-to-Digital Converter (ADC) is a 1 $\mu$ s, 800kSPS, 14-bit sampling A/D converter that draws only 150mW from  $\pm 5V$  supplies. This easy-to-use device includes a high dynamic range sample-and-hold and a precision reference.

Two digitally selectable power shutdown modes provide flexibility for low power systems.

The RAD1419 has a full-scale input range of  $\pm 2.5V$ . Outstanding AC performance includes 81.5dB S/(N + D) and 93dB THD with a 100kHz input; 80dB S/(N + D) and 86dB THD at the Nyquist input frequency of 400kHz.

The unique differential input sample-and-hold can acquire single-ended or differential input signals up to its 20MHz bandwidth. The 60dB common mode rejection allows users to eliminate ground loops and common mode noise by measuring signals differentially from the source.

The ADC has a  $\mu$ P compatible, 14-bit parallel output port. There is no pipeline delay in the conversion results. A separate convert start input and data ready signal (BUSY) ease connections to FIFOs, DPSs and microprocessors.

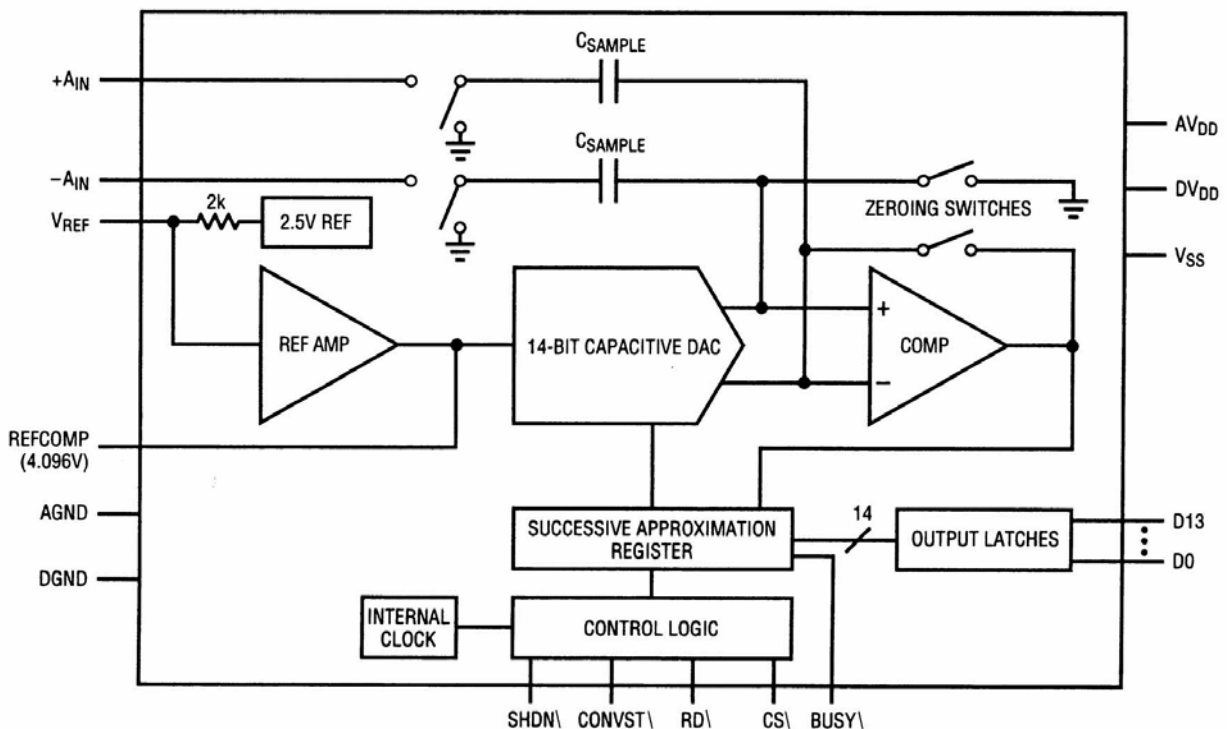
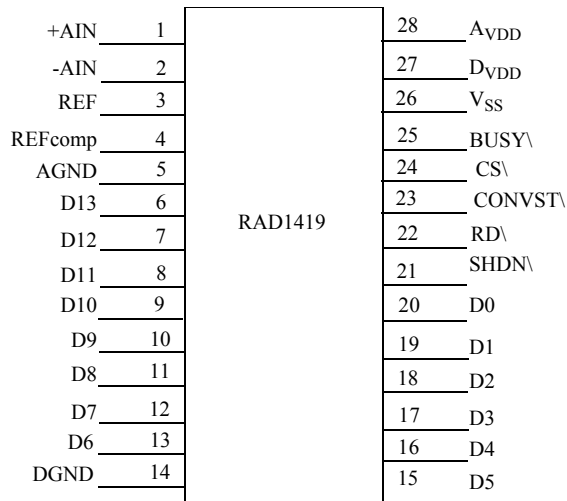


Figure 1. RAD1419 Block Diagram



**Figure 2. RAD1419 Pinout**

## PIN DESCRIPTION

| Pin Name         | No.         | Description   |
|------------------|-------------|---|
| <b>+AIN</b>      | <b>1</b>    | $\pm 2.5V$ Positive analog input  |
| <b>-AIN</b>      | <b>2</b>    | $\pm 2.5V$ Negative analog input  |
| <b>VREF</b>      | <b>3</b>    | 2.5V Reference output. Bypass to AGND with 1 $\mu$ F.   |
| <b>REFcomp</b>   | <b>4</b>    | 4.06V Reference output. Bypass to AGND with 10 $\mu$ F tantalum in parallel with 0.1 $\mu$ F or 10 $\mu$ F ceramic.   |
| <b>AGND</b>      | <b>5</b>    | Analog ground   |
| <b>D13 to D6</b> | <b>6-13</b> | Three-state data outputs. The output format is 2's complement.  |
| <b>DGND</b>      | <b>14</b>   | Digital ground for internal logic. Tie to AGND.   |
| <b>D5 to D0</b>  | <b>0-5</b>  | Three-state data outputs. The output format is 2's complement.  |
| <b>SHDN\</b>     | <b>21</b>   | Power shutdown input. Low selects shutdown. Shutdown mode selected by CS\, CS\ = 0 nap mode and CS\ = 1 for sleep mode.   |
| <b>RD\</b>       | <b>22</b>   | Read input. This enables the output drivers when CS\ is low.  |
| <b>CONVST\</b>   | <b>23</b>   | Conversion start signal. This active low signal starts a conversion on its falling edge.  |
| <b>CS\</b>       | <b>24</b>   | Chip select. The input must be low for the ADC to recognize CONVST\ and RD\ inputs. CS\ also sets the shutdown mode when SHDN\ goes low. CS\ and SHDN\ low select the quick wake-up nap mode. CS\ high and SHDN\ low select sleep mode. |
| <b>BUSY\</b>     | <b>25</b>   | The BUSY\ output shows the converter status. It is low when a conversion is in progress. Data valid on the rising edge of BUSY\.  |
| <b>VSS</b>       | <b>26</b>   | 5V Negative supply. Bypass to AGND with 10 $\mu$ F tantalum in parallel with 0.1 $\mu$ F or 10 $\mu$ F ceramic.   |
| <b>DVDD</b>      | <b>27</b>   | 5V Positive supply. Short to Pin 28.  |
| <b>AVDD</b>      | <b>28</b>   | 5V Positive Supply. Bypass to AGND with 10 $\mu$ F tantalum in parallel with 0.1 $\mu$ F or 10 $\mu$ F ceramic.   |

**OPERATIONAL ENVIRONMENT**

| PARAMETER                    | LIMIT  | UNITS                   |
|------------------------------|--------|-------------------------|
| Total Ionizing Dose (TID)    | 1.0E5  | rad(Si)                 |
| Single Event Latchup (SEL)   | ≤55    | MeV-cm <sup>2</sup> /mg |
| Neutron Fluence <sup>1</sup> | 1.0E13 | n/cm <sup>2</sup>       |

**Notes:**

1. Guaranteed but not tested.

**ABSOLUTE MAXIMUM RATINGS<sup>1</sup>**

(Referenced to V<sub>SS</sub>)

| SYMBOL                             | PARAMETER   | LIMITS        |
|------------------------------------|---|---------------|
| V <sub>DD</sub>                    | Supply voltage                                    | 6.0V          |
| V <sub>SS</sub>                    | Negative supply voltage                           | -6.0V         |
| V <sub>DD</sub> to V <sub>SS</sub> | Total supply voltage                              | 12.0V         |
| T <sub>STG</sub>                   | Storage temperature                               | -65 to +150°C |
| P <sub>D</sub>                     | Maximum power dissipation                         | 500mW         |
| T <sub>J</sub>                     | Maximum junction temperature                      | 150°C         |
| R $\theta$ <sub>JC</sub>           | Thermal resistance, junction-to-case <sup>2</sup> | 7.5°C/Watt    |

**Notes:**

- Stresses outside the listed absolute maximum ratings may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions beyond limits indicated in the operational sections of this specification is not recommended. Exposure to absolute maximum rating conditions for extended periods may affect device reliability and performance.
- Test per MIL-STD-883, Method 1012.

**RECOMMENDED OPERATING CONDITIONS**

| SYMBOL                             | PARAMETER              | LIMITS         |
|------------------------------------|------------------------|----------------|
| V <sub>SS</sub> to V <sub>DD</sub> | Input/output voltage   | -0.5V to +0.5V |
| T <sub>C</sub>                     | Case temperature range | -55 to +125°C  |

## ELECTRICAL CHARACTERISTICS

### CONVERTER CHARACTERISTICS

\*Denotes specifications which apply over the full operating temperature range, otherwise specifications are TA = +25°C. With Internal Reference.<sup>5,6</sup>

| SYMBOL | PARAMETER                           | CONDITIONS                 | GROUP A<br>SUBGROUPS | MIN | TYP  | MAX  | UNITS  |
|--------|-------------------------------------|----------------------------|----------------------|-----|------|------|--------|
|        | Resolution                          | (No Missing Codes)         | 1                    | 14  |      |      | Bits   |
|        |                                     |                            | 2                    |     |      |      |        |
|        |                                     |                            | 3                    |     |      |      |        |
| INL    | Integral Linearity Error            | Note 7                     | 1                    |     | ±0.8 | ±2   | LSB    |
|        |                                     |                            | 2                    |     |      |      |        |
|        |                                     |                            | 3                    |     |      |      |        |
| DNL    | Differential Linearity Error        |                            | 1                    |     | ±0.7 | ±1.5 | LSB    |
|        |                                     |                            | 2                    |     |      |      |        |
|        |                                     |                            | 3                    |     | ±0.7 | ±2   | LSB    |
|        | Offset Error                        | Note 8                     | 1                    |     | ±5   | ±20  | LSB    |
|        |                                     |                            | 2                    |     |      |      |        |
|        |                                     |                            | 3                    |     |      |      |        |
|        | Full scale Error Internal Reference |                            | 1                    |     | ±10  | ±60  | LSB    |
|        | Full scale Error External Reference | 2.5V                       |                      |     | ±5   |      | LSB    |
|        | Full Scale Tempco                   | I <sub>OUT</sub> (REF) = 0 |                      |     | ±15  |      | ppm/°C |

### ANALOG INPUT

\*Denotes specifications which apply over the full operating temperature range, otherwise specifications are TA = +25°C.<sup>5</sup>

| SYMBOL              | PARAMETER                                  | CONDITIONS  | GROUP A<br>SUBGROUPS | MIN | TYP  | MAX | UNITS |
|---------------------|--|---|----------------------|-----|------|-----|-------|
| V <sub>IN</sub>     | Analog Input Range                         | 4.75V ≤ V <sub>DD</sub> ≤ 5.25V,<br>-5.25V ≤ V <sub>SS</sub> ≤ -4.75V * |                      |     | ±2.5 |     | V     |
| I <sub>IN</sub>     | Analog Input Leakage Current               | CS\ = HIGH  | 1                    |     |      | ±1  | μA    |
|                     |  |   | 2                    |     |      |     |       |
|                     |  |   | 3                    |     |      |     |       |
| C <sub>IN</sub>     | Analog Input Capacitance                   | Between Conversions   |                      |     | 15   |     | pF    |
| C <sub>IN</sub>     | Analog Input Capacitance                   | During Conversions  |                      |     | 5    |     | pF    |
| t <sub>ACQ</sub>    | Sample-and-Hold Acquisition Time           | Note 9  |                      |     | 90   | 300 | ns    |
| t <sub>AP</sub>     | Sample-and-Hold Aperture Delay Time        |   |                      |     | -1.5 |     | ns    |
| t <sub>JITTER</sub> | Sample-and-Hold Aperture Delay Time Jitter |   |                      |     | 2    |     | psRMS |
| CMRR                | Analog Input Common Mode Rejection Ratio   | -2.5V < (-AIN = AIN) < 2.5V   |                      |     | 60   |     | dB    |

## DYNAMIC ACCURACY

\*Denotes specifications which apply over the full operating temperature range, otherwise specifications are TA = +25°C.<sup>5</sup>

| SYMBOL    | PARAMETER                            | CONDITIONS   | GROUP A<br>SUBGROUPS | MIN | TYP  | MAX | UNITS |
|-----------|--------------------------------------|--|----------------------|-----|------|-----|-------|
| S/(N + D) | Signal-to (Noise + Distortion) Ratio | 100 KHz Input Signal *   | 4                    | 78  | 81.5 |     | dB    |
| S/(N + D) | Signal-to (Noise + Distortion) Ratio | 390 KHz Input Signal *   |                      |     | 80.0 |     | dB    |
| THD       | Total Harmonic Distortion            | 100 KHz Input Signal, First 5 Harmonics *                      | 4                    |     | -93  | -86 | dB    |
| THD       | Total Harmonic Distortion            | 390 KHz Input Signal, First 5 Harmonics *                      |                      |     | -86  |     | dB    |
| SFDR      | Spurious Free Dynamic Range          | 100 KHz Input Signal *   | 4                    |     | -95  | -86 | dB    |
| IMD       | Intermodulation Distortion           | f <sub>IN1</sub> = 29.37 KHz,<br>f <sub>IN2</sub> = 32.446 KHz |                      |     | -86  |     | dB    |
|           | Full-Power Bandwidth                 |  |                      |     | 20   |     | MHz   |
|           | Full-Linear Bandwidth                | S/(N + D) ≥ 77dB   |                      |     | 1    |     | MHz   |

## INTERNAL REFERENCE CHARACTERISTICS<sup>5</sup>

| SYMBOL           | PARAMETER         | CONDITIONS  | GROUP A<br>SUBGROUPS | MIN   | TYP   | MAX   | UNITS  |
|------------------|-------------------|---|----------------------|-------|-------|-------|--------|
| V <sub>REF</sub> | Output Voltage    | I <sub>OUT</sub> = 0  | 1                    | 2.480 | 2.500 | 2.520 | V      |
|                  |                   |   | 2                    |       |       |       |        |
|                  |                   |   | 3                    |       |       |       |        |
| V <sub>REF</sub> | Output Tempco     | I <sub>OUT</sub> = 0  |                      |       | ±15   |       | ppm/°C |
| V <sub>REF</sub> | Line Regulation   | 4.75V < V <sub>DD</sub> < 5.25V,<br>-5.25V < V <sub>SS</sub> < -4.75V |                      |       | 0.05  |       | LSB/V  |
| V <sub>REF</sub> | Output Resistance | -0.1mA <  I <sub>OUT</sub>   < 0.1mA                                  |                      |       | 2     |       | kΩ     |
| REFCOMP          | Output Voltage    | I <sub>OUT</sub> = 0  |                      |       | 4.06  |       | V      |

## DIGITAL INPUTS AND DIGITAL OUTPUTS

\*Denotes specifications which apply over the full operating temperature range, otherwise specifications are TA = +25°C.<sup>5</sup>

| SYMBOL              | TEST                                | TEST CONDITION   | GROUP A<br>SUBGROUPS | MIN | TYP  | MAX | UNITS |
|---------------------|-------------------------------------|--|----------------------|-----|------|-----|-------|
| V <sub>IH</sub>     | High Level Input Voltage            | V <sub>DD</sub> = 5.25V *<br>Note 12                     | 1                    | 2.4 |      |     | V     |
|                     |                                     |  | 2                    |     |      |     |       |
|                     |                                     |  | 3                    |     |      |     |       |
| V <sub>IL</sub>     | Low Level Input Voltage             | V <sub>DD</sub> = 4.75V *<br>Note 12                     | 1                    |     |      | 0.8 | V     |
|                     |                                     |  | 2                    |     |      |     |       |
|                     |                                     |  | 3                    |     |      |     |       |
| I <sub>IN</sub>     | Digital Input Current               | V <sub>IN</sub> = 0V to V <sub>DD</sub> *                | 1                    |     |      | ±10 | μA    |
|                     |                                     |  | 2                    |     |      |     |       |
|                     |                                     |  | 3                    |     |      |     |       |
| C <sub>IN</sub>     | Digital Input Capacitance           |  |                      |     | 5    |     | pF    |
| V <sub>OH</sub>     | High Level Output Voltage           | V <sub>DD</sub> = 4.75V<br>IO = -10μA*                   |                      |     | 4.5  |     | V     |
| V <sub>OH</sub>     | High Level Output Voltage           | V <sub>DD</sub> = 4.75V<br>IO = -200μA                   | 1                    | 4.0 |      |     | V     |
|                     |                                     |  | 2                    |     |      |     |       |
|                     |                                     |  | 3                    |     |      |     |       |
| V <sub>OL</sub>     | Low Level Output Voltage            | V <sub>DD</sub> = 4.75V<br>IO = 160μA                    |                      |     | 0.05 |     | V     |
| V <sub>OL</sub>     | Low Level Output Voltage            | V <sub>DD</sub> = 4.75V<br>IO = 1.6mA *                  | 1                    |     | 0.10 | 0.4 | V     |
|                     |                                     |  | 2                    |     |      |     |       |
|                     |                                     |  | 3                    |     |      |     |       |
| I <sub>OZ</sub>     | High-Z Output Leakage D13 to D0     | V <sub>OUT</sub> = 0V to V <sub>DD</sub> ,<br>CS\ High * | 1                    |     |      | ±10 | μA    |
|                     |                                     |  | 2                    |     |      |     |       |
|                     |                                     |  | 3                    |     |      |     |       |
| C <sub>OZ</sub>     | High-Z Output Capacitance D13 to D0 | CS\ High, Note 9 *                                       |                      |     |      | 15  | pF    |
| I <sub>SOURCE</sub> | Output Source Current               | V <sub>OUT</sub> = 0V                                    |                      |     | -10  |     | mA    |
| I <sub>SINK</sub>   | Output Sink Current                 | V <sub>OUT</sub> = V <sub>DD</sub>                       |                      |     | 10   |     | mA    |

## POWER REQUIREMENTS

\*Denotes specifications which apply over the full operating temperature range, otherwise specifications are TA = +25°C.<sup>5</sup>

| SYMBOL           | PARAMETER               | CONDITIONS                          | GROUP A<br>SUBGROUPS | MIN   | TYP | MAX   | UNITS |
|------------------|-------------------------|-------------------------------------|----------------------|-------|-----|-------|-------|
| V <sub>DD</sub>  | Positive Supply Voltage | Note 10                             |                      | 4.75  |     | 5.25  | V     |
| V <sub>SS</sub>  | Negative Supply Voltage | Note 10                             |                      | -4.75 |     | -5.25 | V     |
| I <sub>DD</sub>  | Positive Supply Current |                                     | 1                    |       | 11  | 20    | mA    |
|                  |                         |                                     | 2                    |       |     |       |       |
|                  |                         |                                     | 3                    |       |     |       |       |
| I <sub>DD</sub>  | Positive Supply Current | Nap Mode:<br>SHDN\ = 0V, CS\ = 0V   |                      |       | 1.5 |       | mA    |
| I <sub>DD</sub>  | Positive Supply Current | Sleep Mode:<br>SHDN\ = 0V, CS\ = 5V |                      |       | 250 |       | μA    |
| I <sub>SS</sub>  | Negative Supply Current |                                     | 1                    |       | 19  | 30    | mA    |
|                  |                         |                                     | 2                    |       |     |       |       |
|                  |                         |                                     | 3                    |       |     |       |       |
| I <sub>SS</sub>  | Negative Supply Current | Nap Mode:<br>SHDN\ = 0V, CS\ = 0V   |                      |       | 100 |       | μA    |
| I <sub>SS</sub>  | Negative Supply Current | Sleep Mode:<br>SHDN\ = 0V, CS\ = 5V |                      |       | 1   |       | μA    |
| P <sub>DIS</sub> | Power Dissipation       |                                     | 1                    |       | 150 | 240   | mW    |
|                  |                         |                                     | 2                    |       |     |       |       |
|                  |                         |                                     | 3                    |       |     |       |       |
| P <sub>DIS</sub> | Power Dissipation       | Nap Mode:<br>SHDN\ = 0V, CS\ = 0V   | 1                    |       | 7.5 | 1.2   | mW    |
|                  |                         |                                     | 2                    |       |     |       |       |
|                  |                         |                                     | 3                    |       |     |       |       |
| P <sub>DIS</sub> | Power Dissipation       | Sleep Mode:<br>SHDN\ = 0V, CS\ = 5V |                      |       | 1.2 |       | mW    |

## TIMING CHARACTERISTICS

\*Denotes specifications which apply over the full operating temperature range, otherwise specifications are TA = +25°C.<sup>5</sup>

| SYMBOL                       | PARAMETER                     | CONDITIONS         | GROUP A<br>SUBGROUPS | MIN | TYP  | MAX  | UNITS |
|------------------------------|-------------------------------|--------------------|----------------------|-----|------|------|-------|
| f <sub>SAMPLE</sub><br>(MAX) | Maximum Sampling Frequency    | Note 9 *           | 9                    | 800 |      |      | kHz   |
|                              |                               |                    | 10                   |     |      |      |       |
|                              |                               |                    | 11                   |     |      |      |       |
| t <sub>CONV</sub>            | Conversion Time               |                    | 9                    |     | 950  | 1150 | ns    |
|                              |                               |                    | 10                   |     |      |      |       |
|                              |                               |                    | 11                   |     |      |      |       |
| t <sub>ACQ</sub>             | Acquisition Time              | Note 9 *           | 9                    |     | 90   | 300  | ns    |
|                              |                               |                    | 10                   |     |      |      |       |
|                              |                               |                    | 11                   |     |      |      |       |
| t <sub>ACQ</sub> +<br>CONV   | Acquisition + Conversion Time | Note 9 *           | 9                    |     | 1040 | 1250 | ns    |
|                              |                               |                    | 10                   |     |      |      |       |
|                              |                               |                    | 11                   |     |      |      |       |
| t <sub>1</sub>               | CS\ to RD\ Setup Time         | Note 9 *           |                      | 0   |      |      | ns    |
| t <sub>2</sub>               | CS\ to CONVST\ Setup Time     | Note 9 *           |                      | 40  |      |      | ns    |
| t <sub>3</sub>               | CS\ to SHDN\ Setup Time       | Note 9             |                      | 40  |      |      | ns    |
| t <sub>4</sub>               | SHDN\ to CONVST\ Wake-up Time | Note 10            |                      |     | 400  |      | ns    |
| t <sub>5</sub>               | CONVST\ Low Time              | Notes 9, 11 *      | 9                    | 40  |      |      | ns    |
|                              |                               |                    | 10                   |     |      |      |       |
|                              |                               |                    | 11                   |     |      |      |       |
| t <sub>6</sub>               | CONVST\ to BUSY\ Delay        | CL = 25pF          | 9                    |     | 20   |      | ns    |
| t <sub>6</sub>               | CONVST\ to BUSY\ Delay        | CL = 25pF          | 9                    |     |      | 50   | ns    |
|                              |                               |                    | 10                   |     |      |      |       |
|                              |                               |                    | 11                   |     |      |      |       |
| t <sub>7</sub>               | Data Ready Before BUSY\       |                    | 9                    | 20  | 50   |      | ns    |
| t <sub>7</sub>               | Data Ready Before BUSY\       | Note 9             | 9                    | 15  |      |      | ns    |
|                              |                               |                    | 10                   |     |      |      |       |
|                              |                               |                    | 11                   |     |      |      |       |
| t <sub>8</sub>               | Delay Between Conversions     | Note 9 *           | 9                    | 40  |      |      | ns    |
|                              |                               |                    | 10                   |     |      |      |       |
|                              |                               |                    | 11                   |     |      |      |       |
| t <sub>9</sub>               | Wait Time RD\ After BUSY\     | Note 9 *           |                      | -5  |      |      | ns    |
| t <sub>10</sub>              | Data Access Time After RD\    | CL = 25pF          | 9                    |     | 15   | 25   | ns    |
| t <sub>10</sub>              | Data Access Time After RD\    | CL = 25pF, Note 9  | 9                    |     |      | 35   | ns    |
|                              |                               |                    | 10                   |     |      |      |       |
|                              |                               |                    | 11                   |     |      |      |       |
| t <sub>10</sub>              | Data Access Time After RD\    | CL = 100pF, Note 9 | 9                    |     | 20   | 35   | ns    |
| t <sub>10</sub>              | Data Access Time After RD\    | CL = 100pF, Note 9 | 9                    |     |      | 50   | ns    |
|                              |                               |                    | 10                   |     |      |      |       |
|                              |                               |                    | 11                   |     |      |      |       |
| t <sub>11</sub>              | Bus Relinquish Time           | Note 9             | 9                    |     | 10   | 20   | ns    |



## TIMING CHARACTERISTICS (Cont'd)

\*Denotes specifications which apply over the full operating temperature range, otherwise specifications are TA = +25°C.<sup>5</sup>

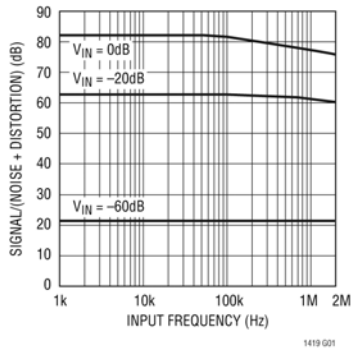
| SYMBOL            | PARAMETER           | CONDITIONS | GROUP A<br>SUBGROUPS | MIN | TYP | MAX | UNITS |
|-------------------|---------------------|------------|----------------------|-----|-----|-----|-------|
| $t_{11}$          | Bus Relinquish Time |            | 9                    |     |     | 35  | ns    |
|                   |                     |            | 10                   |     |     |     |       |
| RD\ Low Time      | $t_{12}$            | Note 9 *   | 9                    | 10  |     |     | ns    |
|                   |                     |            | 10                   |     |     |     |       |
|                   |                     |            | 11                   |     |     |     |       |
| CONVST\ High Time | $t_{13}$            | Note 9 *   | 9                    | 40  |     |     | ns    |
|                   |                     |            | 10                   |     |     |     |       |
|                   |                     |            | 11                   |     |     |     |       |
|                   |                     |            | 11                   |     |     |     |       |

### Notes:

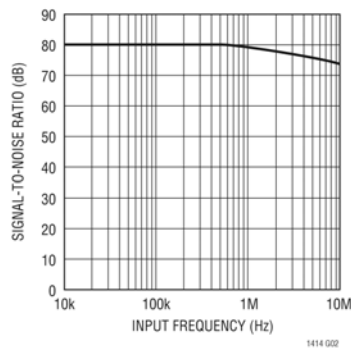
Parameters listed only as "Typical" are not tested in production.

1. Absolute Maximum Ratings are those values beyond which the life of a device may be impaired.
2. All voltage values are with respect to ground with D<sub>GND</sub> and A<sub>GND</sub> wired together unless otherwise noted.
3. When these pin voltages are taken below V<sub>SS</sub> or above V<sub>DD</sub>, they will be clamped by internal diodes. This product can handle input currents greater than 100mA below V<sub>SS</sub> or above V<sub>DD</sub> without latch up.
4. When these pin voltages are taken below V<sub>SS</sub>, they will be clamped by internal diodes. This product can handle input currents greater than 100mA below V<sub>SS</sub> without latch up. These pins are not clamped to V<sub>DD</sub>.
5. V<sub>DD</sub> = 5V, V<sub>SS</sub> = -5V, f<sub>SAMPLE</sub> = 800kHz, tr = tf = 5ns unless otherwise specified.
6. Linearity, offset and full-scale specifications apply for a single ended +A<sub>IN</sub> input with - A<sub>IN</sub> grounded.
7. Integral nonlinearity is defined as the deviation of a code from a straight line passing through the actual endpoints of the transfer curve. The deviation is measured from the center of the quantization band.
8. Bipolar offset is the offset voltage measured from -0.5LSB when the output code flickers between 0000 0000 0000 00 and 1111 1111 1111 11.
9. Guaranteed by design or characterization, not subject to test in production.
10. Recommended operating conditions.
11. The falling edge of CONVST\ starts a conversion. If CONVST\ returns high at a critical point during the conversion it can create small errors. For best performance ensure that CONVST\ returns high either within 650ns after the start of the conversion or after BUSY rises.
12. V<sub>IH</sub> and V<sub>IL</sub> will be guaranteed by testing V<sub>OH</sub> and V<sub>OL</sub> at the appropriate levels.

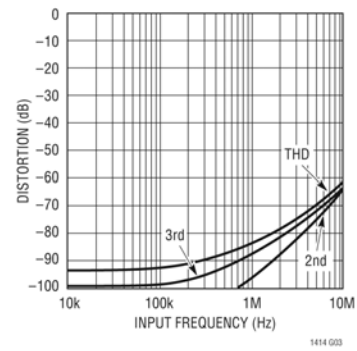
**S/(N+D) vs Input Frequency and Amplitude**



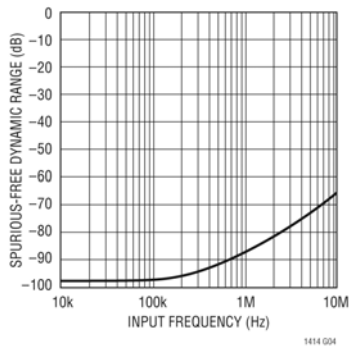
**Signal-to-Noise Ratio**



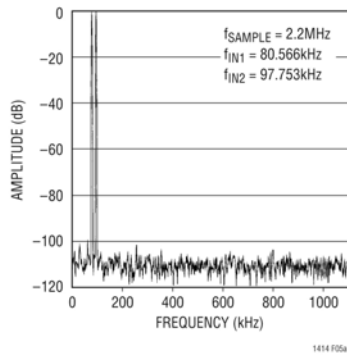
**Distortion vs Input Frequency**



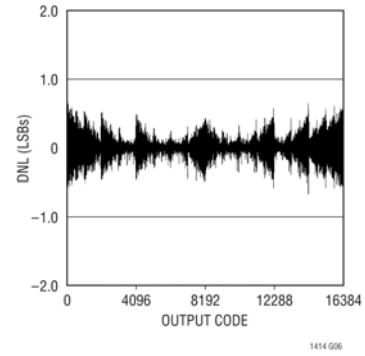
**Spurious-Free Dynamic Range vs Input Frequency**



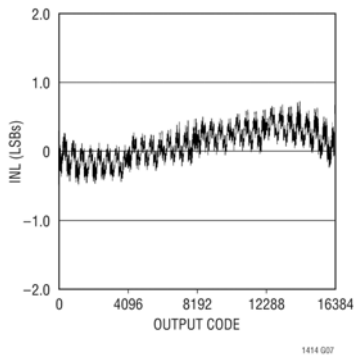
**Intermodulation Distortion Plot**



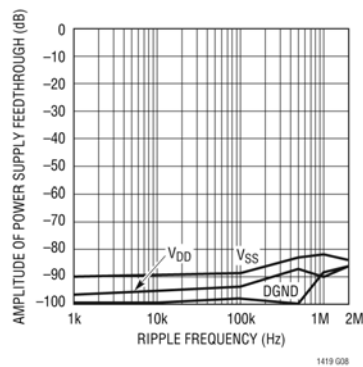
**Differential Nonlinearity vs Output Code**



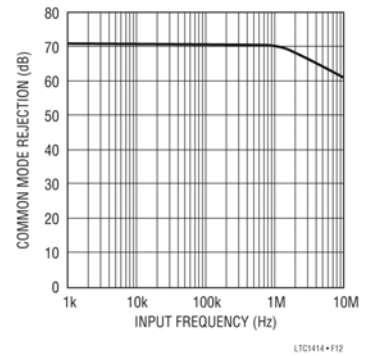
**Integral Nonlinearity vs Output Code**



**Power Supply Feedthrough vs Ripple Frequency**



**Input Common Mode Rejection vs Input Frequency**



**Figure 2. Typical Performance Characteristics**

## ELECTRICAL REQUIREMENTS

| <b>TEST REQUIREMENTS</b>             | <b>SUBGROUPS</b> |
|--------------------------------------|------------------|
| Pre Burn-in electrical parameters    | 1,4,9            |
| Interim electrical parameters        | 1,4,9            |
| Final electrical test parameters     | 1,2,3,4,9,10,11  |
| Post seal electrical test parameters | 1                |
| Group A electrical test parameters   | 1,2,3,4,9,10,11  |
| Group B electrical test parameters   | 1,4,9            |
| Group C electrical test parameters   | 1,4,9            |
| Group D electrical test parameters   | 1,4,9            |

| <b>SUBGROUP</b> | <b>Definitions</b>              |
|-----------------|---------------------------------|
| 1               | Static characteristics 25°C     |
| 2               | Static characteristics 125°C    |
| 3               | Static characteristics -55°C    |
| 4               | Dynamic characteristics 25°C    |
| 5               | Dynamic characteristics 125°C   |
| 6               | Dynamic characteristics -55°C   |
| 9               | Switching characteristics 25°C  |
| 10              | Switching characteristics 125°C |
| 11              | Switching characteristics -55°C |

# PACKAGING

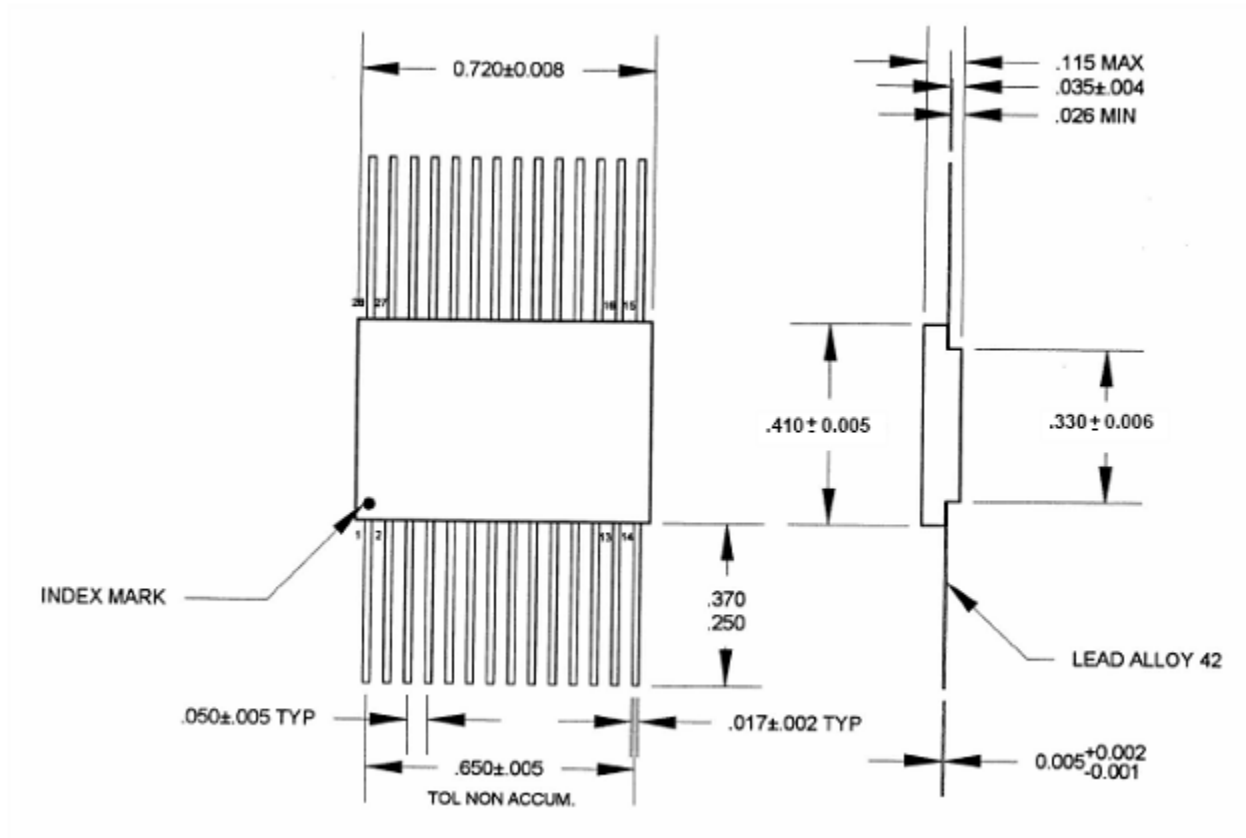
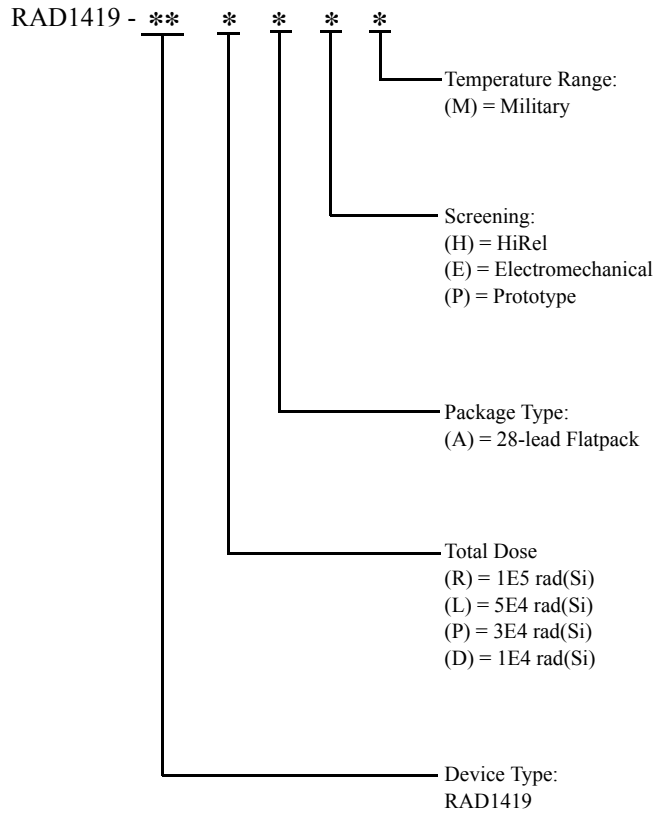


Figure 4. 28-Lead Hermetic Ceramic Flatpack

## ORDERING INFORMATION

### RAD1419:



#### Notes:

1. Military temperature range:  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ .
2. Prototype devices are tested at  $25^{\circ}\text{C}$  only, in a production package.
3. Electromechanical devices are tri-temp tested ( $-55^{\circ}\text{C}$ ,  $25^{\circ}\text{C}$ ,  $125^{\circ}\text{C}$ ), post-assembly screening: fine and gross leak, burn-in a production package.

## *Aeroflex RAD- Datasheet Definition*

**Datasheet - Class S Compliant**

### **COLORADO**

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Fax: 719-594-8468

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Fax: 805-778-1980

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Fax: 603-888-4585

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Fax: 321-951-4254

### **WEST COAST**

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Fax: 949-362-2266

### **CENTRAL**

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Our passion for performance is defined by three attributes represented by these three icons: solution-minded, performance-driven and customer-focused